



# THE DATASHEET OF FDS4465



# FDS4465

## P-Channel 1.8V Specified POWERTRENCH<sup>®</sup> MOSFET

### Description

This P-Channel 1.8 V specified MOSFET is a rugged gate version of ON Semiconductor's advanced POWERTRENCH process. It has been optimized for power management applications with a wide range of gate drive voltage (1.8 V – 8 V).

### Features

- -13.5 A, -20 V
  - ◆  $R_{DS(ON)} = 8.5 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$
  - ◆  $R_{DS(ON)} = 10.5 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$
  - ◆  $R_{DS(ON)} = 14 \text{ m}\Omega @ V_{GS} = -1.8 \text{ V}$
- Fast Switching Speed
- High Performance Trench Technology for Extremely Low  $R_{DS(ON)}$
- High Current and Power Handling Capability

### Applications

- Power Management
- Load Switch
- Battery Protection

### Specifications

#### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Unit
$V_{DSS}$	Drain-to-Source Voltage	-20	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 8$	V
$I_D$	Drain Current	Continuous (Note 1a)	-13.5
		Pulsed	-50
$P_D$	Power Dissipation	(Note 1a)	2.5
		(Note 1b)	1.5
		(Note 1c)	1.2
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +175	$^\circ\text{C}$

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	50	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1c)	125	$^\circ\text{C}/\text{W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Ambient (Note 1)	25	$^\circ\text{C}/\text{W}$

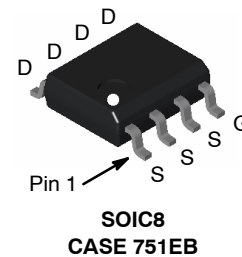
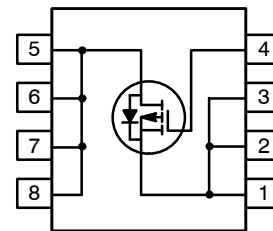


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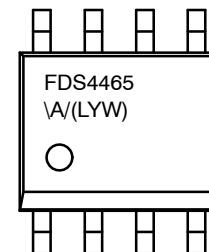
[www.onsemi.com](http://www.onsemi.com)

$V_{DSS}$	$R_{DS(on)}$ MAX	$I_D$ MAX
-20 V	8.5 m $\Omega$ @ -4.5 V	-13.5 A
	10.5 m $\Omega$ @ -2.5 V	
	14 m $\Omega$ @ -1.8 V	

### P-Channel



### MARKING DIAGRAM



A = Assembly Site  
 L = Wafer Lot Number  
 YW = Assembly Start Week  
 FDS4465 = Specific Device Code

### ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

# FDS4465

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	-20			V
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		-12		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -16\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSSF}$	Gate-Body Leakage, Forward	$V_{GS} = 8\text{ V}, V_{DS} = 0\text{ V}$			100	nA
$I_{GSSR}$	Gate-Body Leakage, Reverse	$V_{GS} = -8\text{ V}, V_{DS} = 0\text{ V}$			-100	nA

## ON CHARACTERISTICS (Note 2)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	-0.4	-0.6	-1.5	V
$\Delta V_{GS(th)} / \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$ , Referenced to $25^\circ\text{C}$		3		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = -4.5\text{ V}, I_D = -13.5\text{ A}$		6.7	8.5	m $\Omega$
		$V_{GS} = -2.5\text{ V}, I_D = -12\text{ A}$		8.0	10.5	
		$V_{GS} = -1.8\text{ V}, I_D = -10.5\text{ A}$		9.8	14	
		$V_{GS} = -4.5\text{ V}, I_D = -13.5\text{ A}$	$T_J = 125^\circ\text{C}$	9.0	13	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = -4.5\text{ V}, V_{DS} = -5\text{ V}$	-50			A
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{ V}, I_D = -13.5\text{ A}$		70		S

## DYNAMIC CHARACTERISTICS

$C_{iss}$	Input Capacitance	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$		8237		pF
$C_{oss}$	Output Capacitance			1497		pF
$C_{rss}$	Reverse Transfer Capacitance			750		pF
$R_g$	Gate Resistance		0.1	3.0	6.0	$\Omega$

## SWITCHING CHARACTERISTICS (Note 2)

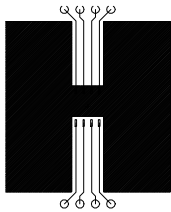
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\text{ V}, I_D = -1\text{ A}, V_{GS} = -4.5\text{ V}, R_{GEN} = 6\ \Omega$		20	36	ns
$t_r$	Turn-On Rise Time			24	38	ns
$t_{d(off)}$	Turn-Off Delay Time			300	480	ns
$t_f$	Turn-Off Fall Time			140	224	ns
$Q_g$	Total Gate Charge	$V_{DS} = -10\text{ V}, I_D = -1\text{ A}, V_{GS} = -4.5\text{ V}$		86	120	nC
$Q_{gs}$	Gate-Source Charge			20		nC
$Q_{gd}$	Gate-Drain Charge			11		nC

## DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

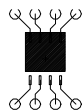
$I_S$	Maximum Continuous Drain-Source Diode Forward Current			-2.1	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -2.1\text{ A}$ (Note 2)		-0.6	-1.2	V

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

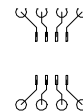
- $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a)  $50^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper



b)  $105^\circ\text{C/W}$  when mounted on a  $.04\text{ in}^2$  pad of 2 oz copper



c)  $125^\circ\text{C/W}$  when mounted on a minimum pad

Scale 1:1 on letter size paper

- Pulse Test: Pulse Width <  $300\ \mu\text{s}$ , Duty Cycle < 2.0%

TYPICAL CHARACTERISTICS

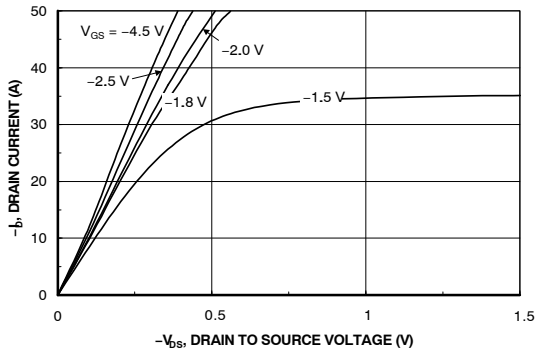


Figure 1. On-Region Characteristics

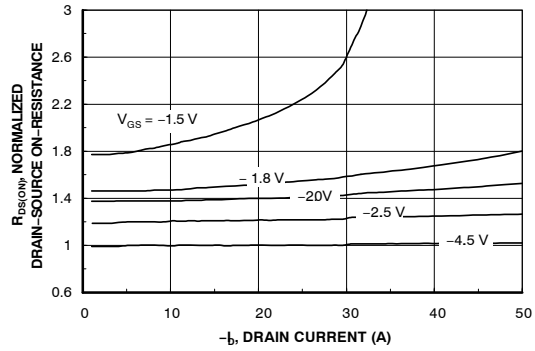


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

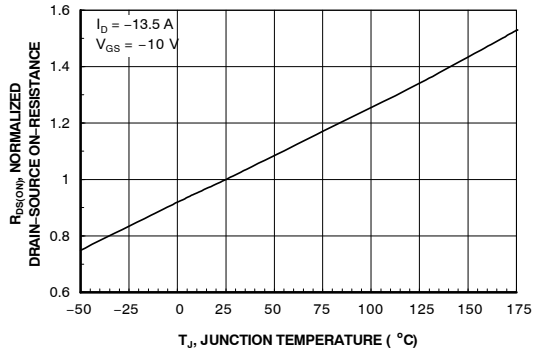


Figure 3. On-Resistance Variation with Temperature

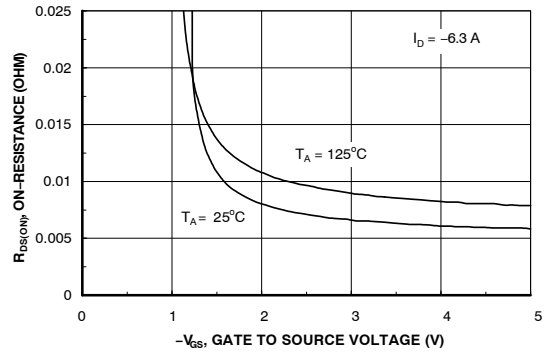


Figure 4. On-Resistance Variation with Gate-to-Source Voltage

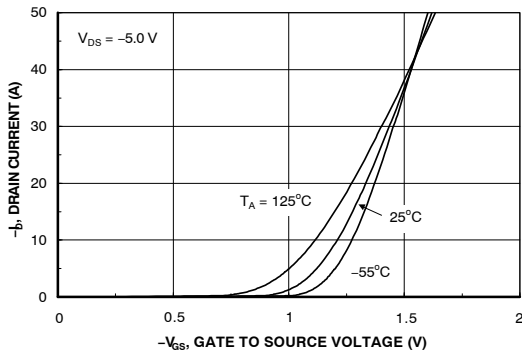


Figure 5. Transfer Characteristics

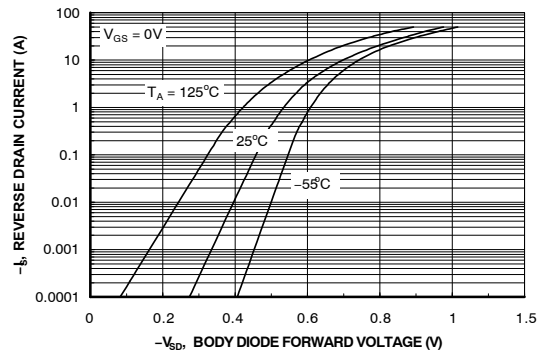


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

TYPICAL CHARACTERISTICS

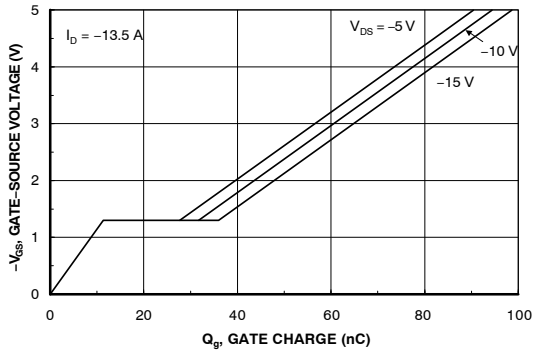


Figure 7. Gate Charge Characteristics

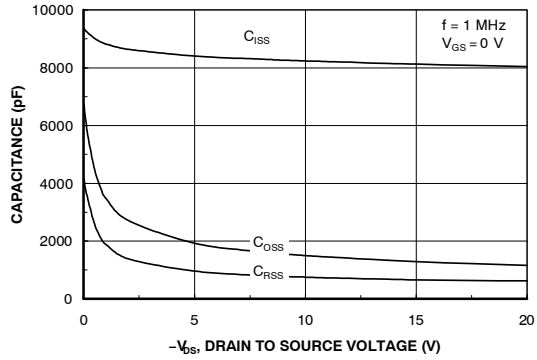


Figure 8. Capacitance Characteristics

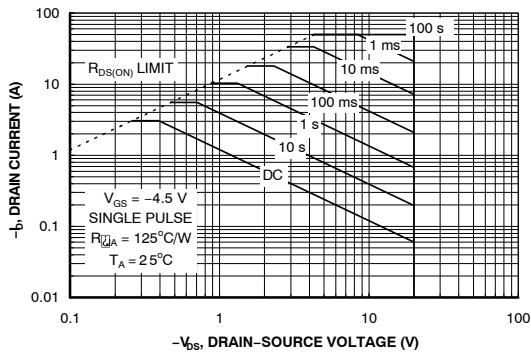


Figure 9. Maximum Safe Operating Area

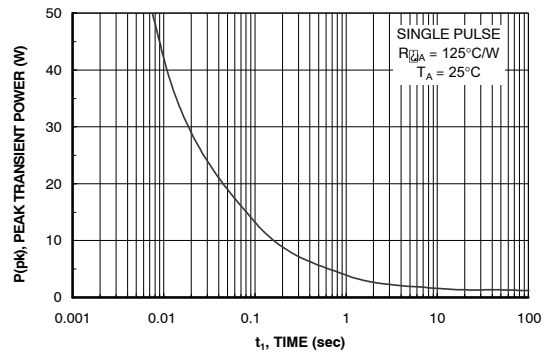


Figure 10. Single Pulse Maximum Power Dissipation

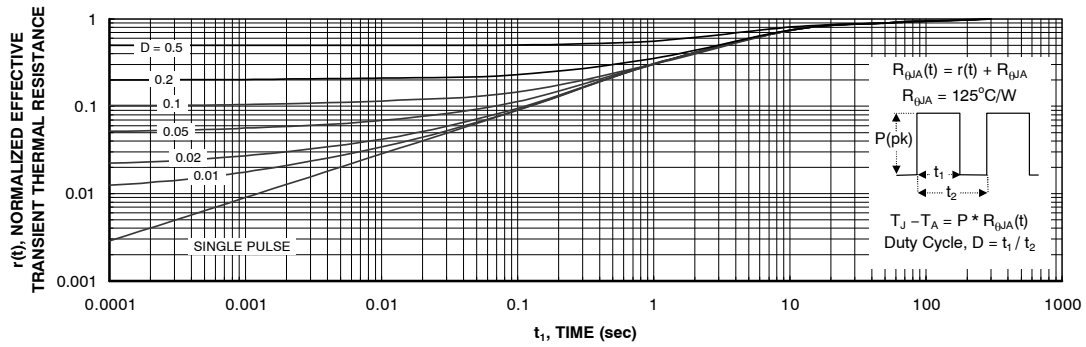


Figure 11. Transient Thermal Response Curve

Thermal characterization performed using the conditions described in Note 1c.  
 Transient thermal response will change depending on circuit board design.

# FDS4465

## PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Reel Size	Tape Width	Shipping <sup>†</sup>
FDS4465	FDS4465	13"	12 mm	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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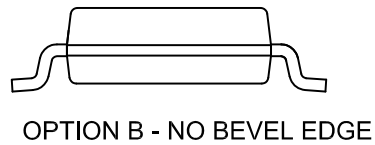
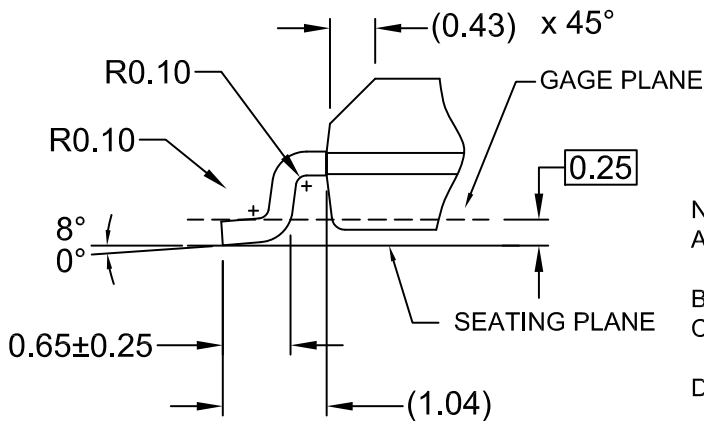
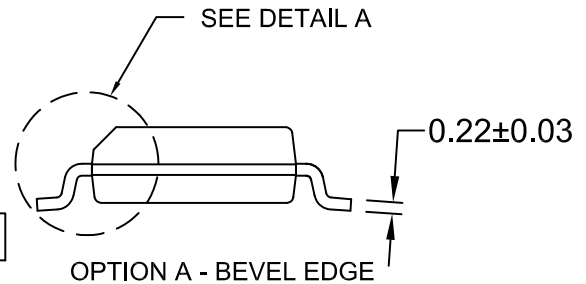
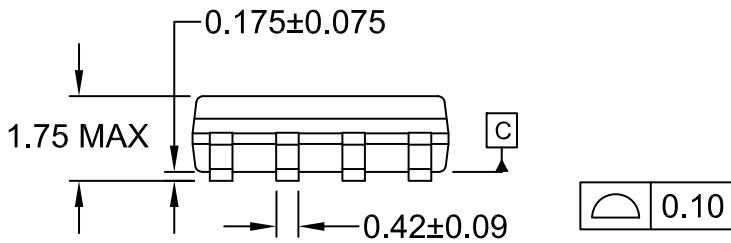
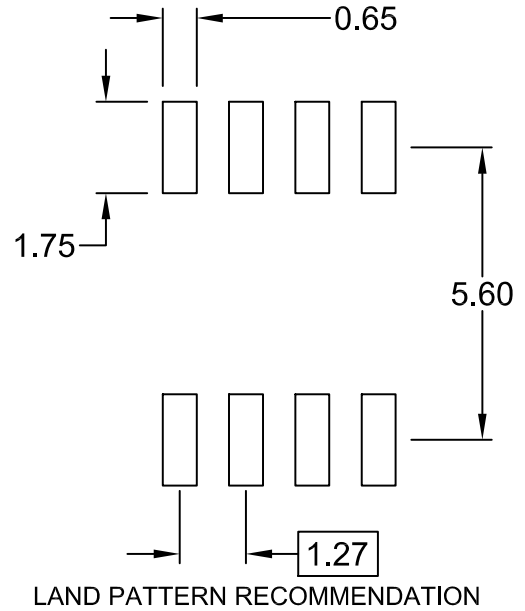
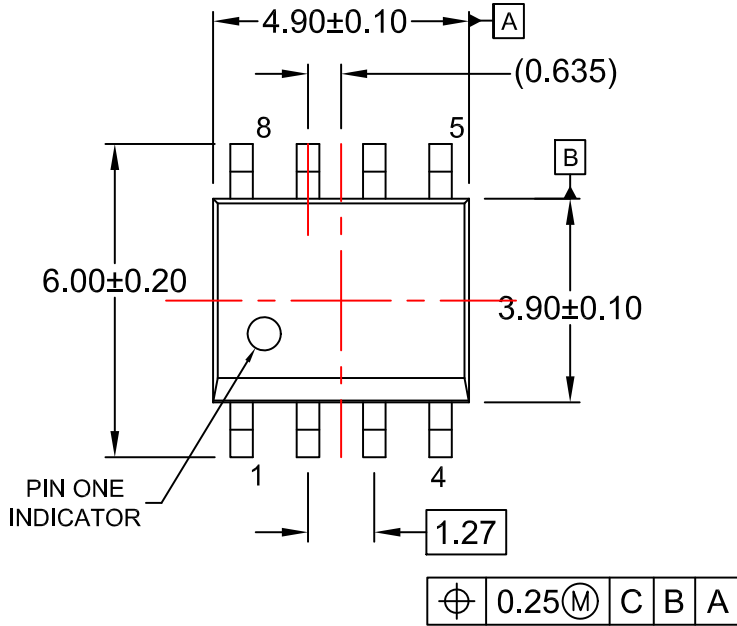
**MECHANICAL CASE OUTLINE**  
**PACKAGE DIMENSIONS**

ON Semiconductor®



**SOIC8**  
**CASE 751EB**  
**ISSUE A**

DATE 24 AUG 2017




- NOTES:
- A) THIS PACKAGE CONFORMS TO JEDEC MS-012, VARIATION AA.
  - B) ALL DIMENSIONS ARE IN MILLIMETERS.
  - C) DIMENSIONS DO NOT INCLUDE MOLD FLASH OR BURRS.
  - D) LANDPATTERN STANDARD: SOIC127P600X175-8M

**DETAIL A**  
 SCALE: 2:1

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<b>NEW STANDARD:</b>		
<b>DESCRIPTION:</b>	<b>SOIC8</b>	<b>PAGE 1 OF 2</b>



ISSUE	REVISION	DATE
O	RELEASED FOR PRODUCTION FROM FAIRCHILD M08A TO ON SEMICONDUCTOR. REQ. BY B. MARQUIS.	30 SEP 2016
A	CORRECTED DIMENSIONAL ERROR IN DETAIL A. REQ. BY H. ALLEN.	24 AUG 2017

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